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FILE NAM CHIP SERIE ±0.5%,±		DATE	2012.11.02	EDITION NO.	1
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EDITION	PRESCRIPTION OF AMENDMENT	AMEND PAGE	AMEND DATE	AMENDED BY	CHECKED BY

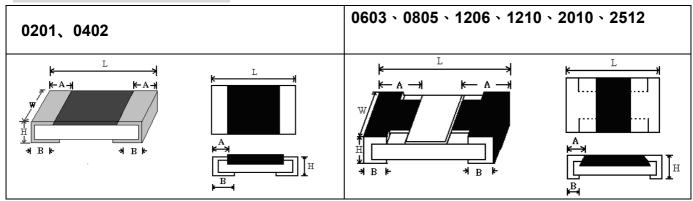
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SUPEROHM

1.0 SCOPE:

THIS SPECIFICATION FOR APPROVE RELATES TO THE LEAD-FREE THICK FILM CHIP RESISTORS MANUFACTURED BY SUPEROHM.

2.0 RATINGS & DIMENSION:



UNIT: mm

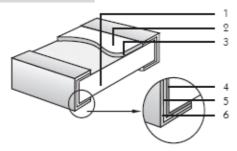
TYPE		0201	0402	0603	0805	1206	1210	2010	2512
POWER RATING AT	70 ℃	1/20W	1/16W	1/10W	1/8W	1/4W	1/3W	3/4W	1W (2WS)
	L	0.60±0.03	1.0±0.10	1.60±0.10	2.00±0.15	3.10±0.15	3.10±0.10	5.00±0.10	6.35±0.10
	W	0.30±0.03	0.50±0.05	+0.15 0.80 -0.10	+0.15 1.25 -0.10	+0.15 1.55 -0.10	+0.15 2.60 -0.10	+0.15 2.50 -0.10	+0.15 3.20 -0.10
DIMENSION(MM)	Н	0.23±0.03	0.35±0.05	0.45±0.10	0.55±0.10	0.55±0.10	0.55±0.10	0.55±0.10	0.55±0.10
	Α	0.10±0.05	0.20±0.10	0.30±0.20	0.40±0.20	0.45±0.20	0.50±0.25	0.60±0.25	0.60±0.25
	В	0.15±0.05	0.25±0.10	0.30±0.20	0.40±0.20	0.45±0.20	0.50±0.20	0.50±0.20	0.50±0.20
RESISTANCE VALU	JE	< 50m Ω	$<$ 50m Ω	< 50m Ω					
JUMPER RATED CURRENT		0.5A	1A	1A	2A	2A	2A	2A	2A
JUMPER RATED M OVERLOAD CURRENT	IAX	1A	2A	2A	5A	10A	10A	10A	10A
MAX WORKING VOLTAGE		25V	50V	50V	150V	200V	200V	200V	200V
MAX OVERLOAD VOLTAGE		50V	100V	100V	300V	400V	500V	500V	500V
DIELECTRIC WITHSTANDING VOLTAGE			100V	300V	500V	500V	500V	500V	500V
±0.5%			1 Ω -10M Ω						
±1%		1Ω-10ΜΩ	0.2 Ω 22M Ω	0.1Ω 33MΩ	0.1 Ω 33M Ω	0.1 Ω 33M Ω	0.1 Ω 10M Ω	0.1 Ω 22M Ω	0.1 Ω 33MΩ
±2%		1Ω-10ΜΩ	0.2 Ω 22M Ω	0.1Ω 33MΩ	0.1 Ω 33M Ω	0.1 Ω 33M Ω	0.1Ω 22M Ω	0.1 Ω 22M Ω	0.1 Ω 33MΩ
±5%		1 Ω- 10M Ω	0.2 Ω 22M Ω	0.1 Ω 100M Ω	0.1 Ω 100M Ω	0.1 Ω 100M Ω	0.1 Ω 100M Ω	0.1 Ω 22M Ω	0.1 Ω 33M Ω

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OPERATING	FE°0
	-55°C ~ +155°C
TEMPERATURE	

3.0 STRUCTURE:

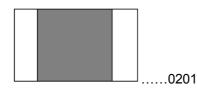


- 1. High purity alumina substrate
- 2. Protective covering
- 3. Resistance element
- 4. Termination (inner) Ni/Cr
- 5. Termination (between) Ni Barrier
- 6. Termination (outer) Sn

4.0 MARKING:

(1) FOR 0201 AND 0402 SIZE. DUE TO THE VERY SMALL SIZE OF THE RESISTOR'S BODY, THERE IS NO MARKING ON THE BODY.

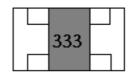
EXAMPLE:





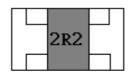
.....0402

(2) $\pm 2\%, \pm 5\%$ TOLERANCE: THE FIRST TWO DIGITS ARE SIGNIFICANT FIGURES OF RESISTANCE AND THE THIRD DENOTES NUMBER OF ZEROS FOLLOWING EXAMPLE:



 $33000 \rightarrow 33 \text{K}\Omega$

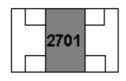
(3) $\pm 2\% \times \pm 5\%$ TOLERANCE: BELOW 10 Ω SHOW AS FOLLOWING, READ ALPHABET"R" AS DECIMAL POINT. EXAMPLE:



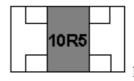
 $2R2 \rightarrow 2.2\Omega$

(4) $\pm 0.5\% \times \pm 1\%$ TOLERANCE: 4 DIGITS, FIRST THREE DIGITS ARE SIGNIFICANT; FORTH DIGIT IS NUMBER OF ZEROS. LETTER R IS DECIMAL POINT.

EXAMPLE:



 $2701 \rightarrow 2.7 \text{K}\Omega$



 $10R5 \rightarrow 10.5\Omega$

(5) STANDARD E-96 SERIES VALUES ($\pm 0.5\% \times \pm 1\%$ TOLERANCE) OF 0603 SIZE. DUE THE SMALL SIZE OF THE RESISTOR'S BODY, 3 DIGITS MARKING WILL BE USED TO INDICATE THE ACCURATE RESISTANCE VALUE BY USING THE FOLLOWING MULTIPLIER & RESISTANCE CODE.

MULTIPLIER CODE:

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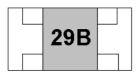
CODE	Α	В	С	D	E	F	G	Н	Х	Y	Z
MULTIPLIER	10°	10 ¹	10 ²	10 ³	10 ⁴	10 ⁵	10 ⁶	10 ⁷	10 ⁻¹	10 ⁻²	10 ⁻³

CODING FORMULA

FIRST TWO DIGITS-----RESISTANCE CODE

THIRD DIGIT------MULTIPLIER CODE

EXAMPLE: 1.96KΩ= 196×10^{1} Ω-----29B



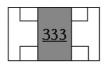
 $12.4\Omega = 124 \times 10^{-1}\Omega - --- 10X$



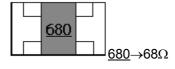
STANDARD E-96 VALUES AND 0603 RESISTANCE CODE

Ω VALUE	CODE	Ω VALUE	CODE	Ω VALUE	CODE	Ω VALUE	CODE
100	01	178	25	316	49	562	73
102	02	182	26	324	50	576	74
105	03	187	27	332	51	590	75
107	04	191	28	340	52	604	76
110	05	196	29	348	53	619	77
113	06	200	30	357	54	634	78
115	07	205	31	365	55	649	79
118	08	210	32	374	56	665	80
121	09	215	33	383	57	681	81
124	10	221	34	392	58	698	82
127	11	226	35	402	59	715	83
130	12	232	36	412	60	732	84
133	13	237	37	422	61	750	85
137	14	243	38	432	62	768	86
140	15	249	39	442	63	787	87
143	16	255	40	453	64	806	88
147	17	261	41	464	65	825	89
150	18	267	42	475	66	845	90
154	19	274	43	487	67	866	91
158	20	280	44	499	68	887	92
162	21	287	45	511	69	909	93
165	22	294	46	523	70	931	94
169	23	301	47	536	71	953	95
174	24	309	48	549	72	976	96

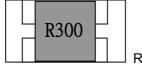
(6) STANDARD E-24 AND NOT BELONG TO E-96 SERIES VALUES(IN ±0.5% \ ±1%TOLERANCE)OF 0603 SIZE THE MARKING IS THE SAME AS 5% TOLERANCE BUT MARKING AS UNDERLINE



 $\underline{\mathbf{333}}\mathbf{=}\mathbf{33000}\mathbf{\rightarrow}\mathbf{33K}\Omega$



(7) PRODUCT BELOW 1Ω , SHOW AS FOLLOWING, THE FIRST DIGIT IS "R" WHICH AS DECIMAL POINT.



R300 \rightarrow 0.3 Ω

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(8) 0Ω MARKING:

NORMALLY FOR 0201 AND 0402 SIZE, NO MARKING ON THE BODY:

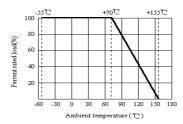


NORMALLY, THE MAKING OF 0Ω 0603, 0Ω 0805, 0Ω 1206, 0Ω 1210, 0Ω 2010, 0Ω 2512 RESISTORS AS FOLLOWING



5.0 POWER RATING:

RESISTORS SHALL HAVE A POWER RATING BASED ON CONTINUOUS LOAD OPERATION AT AN AMBIENT TEMPERATURE FROM -50 $^\circ$ C . FOR TEMPERATURE IN EXCESS OF 70 $^\circ$ C , THE LOAD SHALL BE DERATE AS SHOWN IN FIGURE 1



5.1 VOLTAGE RATING:

RESISTORS SHALL HAVE A RATED DIRECT-CURRENT (DC) CONTINUOUS WORKING VOLTAGE OR AN APPROXIMATE SINE-WAVE ROOT-MEAN-SQUARE (RMS) ALTERNATING-CURRENT (AC) CONTINUOUS WORKING VOLTAGE AT COMMERCIAL-LINE FREQUENCY AND WAVEFORM CORRESPONDING TO THE POWER RATING, AS DETERMINED FROM THE FOLLOWING FORMULA: $RCWV = \sqrt{P \times R}$

WHERE: RCWV COMMERCIAL-LINE FREQUENCY AND WAVEFORM (VOLT.)

P = POWER RATING (VATT.) R = NOMINAL RESISTANCE (OHM)

IN NO CASE SHALL THE RATED DC OR RMS AC CONTINUOUS WORKING VOLTAGE BE GREATER THAN THE APPLICABLE MAXIMUM VALUE.

THE OVERLOAD VOLTAGE IS 2.5 TIMES RCWV OR MAX. OVERLOAD VOLTAGE WHICHEVER IS LESS.

6.0 PERFORMANCE SPECIFICATION:

CHARACTERISTIC	LIMITS	TEST METHOD (JIS-C-5201& JIS-C-5202)
©TEMPERATURE COEFFICIENT	0201: 1Ω≦ R ≤10Ω: ±400PPM/°C >10Ω: ±200PPM/°C	4.8 NATURAL RESISTANCE CHANGES PER TEMP. DEGREE CENTIGRADE

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$\begin{array}{c ccccccccccccccccccccccccccccccccccc$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$
$ \begin{array}{c c} 100\Omega \leq R < 100M\Omega \leq \pm 100PPM/^{\circ}C \\ 10M\Omega \leq R < 100M\Omega \leq \pm 200PPM/^{\circ}C \\ \hline \\ \pm 0.5\%, \pm 1\% \\ \hline \end{array} \begin{array}{c} \pm (1\% + 0.1\Omega) \text{ MAX.} \\ \hline \end{array} \begin{array}{c} \text{TEST PATTERN: ROOM TEMP. (T_1), ROOM TEMP. +100} \\ \hline \\ (T_2) \\ \hline \\ 4.13 \text{ PERMANENT RESISTANCE CHANGE AFTER THE APPLICATION OF A POTENTIAL OF 2.5 TIMES RCWV} \\ \hline \end{array} $
$ \begin{array}{c c} 10M\Omega \leq R < 100M\Omega \leq \pm 200PPM/C \\ \hline $
APPLICATION OF A POTENTIAL OF 2.5 TIMES RCWV
* Δ R<50M Ω APPLY MAX OVERLOAD CURRENT FOR 0 Ω
* DIELECTRIC WITHSTANDING VOLTAGE NO EVIDENCE OF FLASHOVER MECHANICAL DAMAGE, ARCING OR INSULATION BREAKS DOWN. 4.7 RESISTORS SHALL BE CLAMPED IN THE TROUGH A 90°C METALLIC V-BLOCK AND SHALL BE TESTED AT POTENTIAL RESPECTIVELY SPECIFIED IN THE GIVE LIST OF EACH PRODUCT TYPE FOR 60-70 SECONDS
WAVE SOLDER: 95% COVERAGE MIN. TEST TEMPERATURE OF SOLDER: 245°C±3°C DIPPIN TIME IN SOLDER: 2-3 SECONDS.
REFLOW:
SOLDERABILITY PEAK VALUE TEMPERATURE:
GO UP TIN RATE BIGGER THAN 250 2300 1800-1810-1811
HALF OF END POLE 150 1500
100
50 HOT UP TIME SOLDER TIME
4.19RESISTANCE CHANGE AFTER CONTINUOUS FIV
$\pm 0.5\%, \pm 1\%$ $\pm (0.5\% \pm 0.05 \Omega)$ MAX CYCLES FOR DUTY CYCLE SPECIFIED BELOW:
STEP TEMPERATURE TIME
© TEMPERATURE 1 -55°C±3°C 30 MINS
○ TEMPERATURE CYCLING 1 -55°C±3°C 30 MINS 2 ROOM TEMP. 10 15 MINS
© TEMPERATURE CYCLING 1 -55°C±3°C 30 MINS 2 ROOM TEMP. 10 15 MINS ±2%,±5% ±(1.0%+0.05 Ω) MAX 3 +155°C±2°C 30 MINS
○ TEMPERATURE CYCLING 1 -55°C±3°C 30 MINS 2 ROOM TEMP. 10 15 MINS
© TEMPERATURE CYCLING 1 -55°C±3°C 30 MINS 2 ROOM TEMP. 10 15 MINS 3 +155°C±2°C 30 MINS 4 ROOM TEMP. 10 15 MINS 4 ROOM TEMP. 10 15 MINS 4 SOLDERING 4.18 DIP THE RESISTOR INTO A SOLDER BATH HAVING
○ TEMPERATURE CYCLING
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$
TEMPERATURE CYCLING1 -55° C±3°C30 MINS±2%,±5%±(1.0%+0.05 Ω) MAX2ROOM TEMP.10 15 MINS3 $+155^{\circ}$ C±2°C30 MINS4ROOM TEMP.10 15 MINS8ESISTANCE CHANGE RATE IS: ±(1%+0.05 Ω) MAX4.18 DIP THE RESISTOR INTO A SOLDER BATH HAVING TEMPERATURE OF 260°C±5°C AND HOLD IT FOR 1025 SECONDS.9ERMINAL BENDING±(1%+0.05 Ω) MAX4.33 TWIST OF TEST BOARD: Y/X = 3/90 MM FOR 60SECONDS10* INSULATION RESISTANCE4.6 THE MEASURING VOLTAGE SHALL BE ,MEASURE WITH A DIRECT VOLTAGE OF (100±15)V OR A VOLTAGE EQUAL TO THE DIELECTRIC WITHSTANDING VOLTAGE
TEMPERATURE CYCLING1 -55° C±3°C30 MINS±2%,±5%±(1.0%+0.05 Ω) MAX2ROOM TEMP.10 15 MINS3 $+155^{\circ}$ C±2°C30 MINS4ROOM TEMP.10 15 MINS8ESISTANCE CHANGE RATE IS: ±(1%+0.05 Ω) MAX4.18 DIP THE RESISTOR INTO A SOLDER BATH HAVING TEMPERATURE OF 260°C±5°C AND HOLD IT FOR 1025 SECONDS.9ERMINAL BENDING±(1%+0.05 Ω) MAX4.33 TWIST OF TEST BOARD: Y/X = 3/90 MM FOR 60SECONDS10* INSULATION RESISTANCE4.6 THE MEASURING VOLTAGE SHALL BE ,MEASURE WITH A DIRECT VOLTAGE OF (100±15)V OR A VOLTAGE EQUAL TO THE DIELECTRIC WITHSTANDING VOLTAGE
TEMPERATURE CYCLING
$ \begin{array}{ c c c c c } \hline \text{O TEMPERATURE} \\ \hline \text{CYCLING} \\ \hline \\ & \pm 2\%, \pm 5\% \\ \hline \\ & \pm (1.0\% \pm 0.05\Omega) \text{ MAX} \\ \hline \\ $
$ \begin{array}{ c c c c c } \hline \text{TEMPERATURE} \\ \hline \text{CYCLING} \\ \hline \\ & \pm 2\%, \pm 5\% \\ \hline \\ & \pm (1.0\% + 0.05\Omega) \text{ MAX} \\ \hline \\ \hline \\ & \pm 2\%, \pm 5\% \\ \hline \\ & \pm (1.0\% + 0.05\Omega) \text{ MAX} \\ \hline \\ \hline \\ & \pm 2\%, \pm 5\% \\ \hline \\ & \pm (1.0\% + 0.05\Omega) \text{ MAX} \\ \hline \\ \hline \\ & \pm (1\% + 0.05\Omega) \text{ MAX} \\ \hline \\ \hline \\ & \pm (1\% + 0.05\Omega) \text{ MAX} \\ \hline \\ \hline \\ & \pm (1\% + 0.05\Omega) \text{ MAX} \\ \hline \\ & \pm (1\% + 0.05\Omega) \text{ MAX} \\ \hline \\ \hline \\ & \pm (1\% + 0.05\Omega) \text{ MAX} \\ \hline \\ & \pm (1\% + 0.05$
© TEMPERATURE CYCLING1 -55° C±3 $^{\circ}$ C30 MINS $\pm 2\%, \pm 5\%$ $\pm (1.0\% + 0.05 \Omega)$ MAX2ROOM TEMP. $10 15$ MINS $\pm 2\%, \pm 5\%$ $\pm (1.0\% + 0.05 \Omega)$ MAX3 $\pm 155^{\circ}$ C±2 $^{\circ}$ C30 MINS $\pm (1\% + 0.05\Omega)$ MAX4ROOM TEMP. $10 15$ MINS $\pm (1\% + 0.05\Omega)$ MAX4.18 DIP THE RESISTOR INTO A SOLDER BATH HAVIN TEMPERATURE OF 260° C±5 $^{\circ}$ C AND HOLD IT FOR 10 S SECONDS. $\pm (1\% + 0.05\Omega)$ MAX $\pm (1\% + 0.05\Omega)$ MAX4.33 TWIST OF TEST BOARD: Y/X = 3/90 MM FOR 60 SECONDS* INSULATION RESISTANCE $\pm (1\% + 0.05\Omega)$ MAX4.6 THE MEASURING VOLTAGE SHALL BE ,MEASURE WITH A DIRECT VOLTAGE OF (100 ± 15) V OR A VOLTAGE QUAL TO THE DIELECTRIC WITHSTANDING VOLTAGE AND APPLY FOR 1MIN \oplus HUMIDITY (STEADY STATE) $\pm (0.5\% + 0.1\Omega)$ MAX.4.24TEMPORARY RESISTANCE CHANGE AFTER 240 HOURS EXPOSURE IN A HUMIDITY TEST CHAMBER CONTROLLED AT $40\pm2^{\circ}$ C AND $90-95\%$ RELATIVE HUMIDITY.

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⊚ *LOAD LIFE	±0.5%,±1%	±(1%+0.1Ω)MAX.	4.25.1 PERMANENT RESISTANCE CHANGE AFTER 1,000 HOURS OPERATING AT RCWV WITH DUTY CYCLE 1.5			
	±2%,±5% ±(3%+0.1Ω)MAX		HOURS "ON", 0.5 HOUR "OFF" AT 70°C±2°C AMBIENT.			
	* ΔR<50MΩ		APPLY TO RATED CURRENT FOR 0Ω			

THE RESISTORS OF 0Ω ONLY CAN DO THE CHARACTERISTIC NOTED OF * THE RESISTORS OF 0201 ONLY CAN DO THE CHARACTERISTIC NOTED OF \odot

7.0 EXPLANATION OF PART NO. SYSTEM:

THE STANDARD PART NO. INCLUDES 14 DIGITS WITH THE FOLLOWING EXPLANATION:

7.1 1TH~4TH DIGITS

THIS IS TO INDICATE THE CHIP RESISTOR.

EXAMPLE:

0201, 0402,0603,0805,1206,1210,2010,2512

7.2 5TH~6TH DIGITS:

7.2.1 THIS IS TO INDICATE THE WATTAGE OR POWER RATING. TO DIETING THE SIZE AND THE NUMBERS.

THE FOLLOWING CODES ARE USED; AND PLEASE REFER TO THE FOLLOWING CHART FOR DETAIL:

W=NORMAL SIZE; S=SMALL SIZE; U=EXTRA SMALL SIZE; "1" ~ "G" TO DENOTES "1" ~ "16" AS HEXADECIMAL:

1/16W~1W:

WATTAGE	3/4	1/2	1/3	1/4	1/8	1/10	1/16	1
NORMAL SIZE	07	W2	W3	W4	W8	WA	WG	1W
SMALL SIZE	07	S2	S3	S4	S8	SA	SG	1S
ULTRA SMALL SIZE	/	U2	U3	U4	U8	UA	UG	1U

7.2.2 FOR POWER RATING LESS THAN 1 WATT, THE 5TH DIGIT WILL BE THE LETTERS W OR S TO REPRESENT THE SIZE REQUIRED & THE 6TH DIGIT WILL BE A NUMBER OR A LETTER CODE.

EXAMPLE:

WA=1/10W: S4=1/4W-S

7.3 THE 7TH DIGIT IS TO DENOTE THE RESISTANCE TOLERANCE. THE FOLLOWING LETTER CODE IS TO BE USED FOR INDICATING THE STANDARD RESISTANCE TOLERANCE.

 $D=\pm 0.5\%$

F=±1%

G=±2%

J=±5%

 $K = \pm 10\%$

7.4 THE 8TH TO 11TH DIGITS IS TO DENOTE THE RESISTANCE VALUE.

7.4.1 FOR THE STANDARD RESISTANCE VALUES OF E-24 SERIES, THE 8TH DIGIT IS

"0", THE 9TH & 10TH DIGITS ARE TO DENOTE THE SIGNIFICANT FIGURES OF THE RESISTANCE AND THE 11TH DIGIT IS THE NUMBER ZEROS FOLLOWING:

FOR THE STANDARD RESISTANCE VALUES OF E-96 SERIES, THE 8TH DIGIT TO THE 10TH DIGITS IS TO DENOTE THE SIGNIFICANT FIGURES OF THE RESISTANCE AND THE 11TH DIGIT IS THE ZEROS FOLLOWING.

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7.4.2 THE FOLLOWING NUMBER S AND THE LETTER CODES ARE TO BE USED TO INDICATE THE NUMBER OF ZEROS IN THE 11TH DIGIT:

 $0=10^{0}$ $1=10^{1}$ $2=10^{2}$ $3=10^{3}$ $4=10^{4}$ $5=10^{5}$

 $6=10^6$ J= 10^{-1} K= 10^{-2} L= 10^{-3} M= 10^{-4}

7.4.3 THE 12TH, 13TH & 14TH DIGITS.

THE 12TH DIGIT IS TO DENOTE THE PACKAGING TYPE WITH THE FOLLOWING CODES:

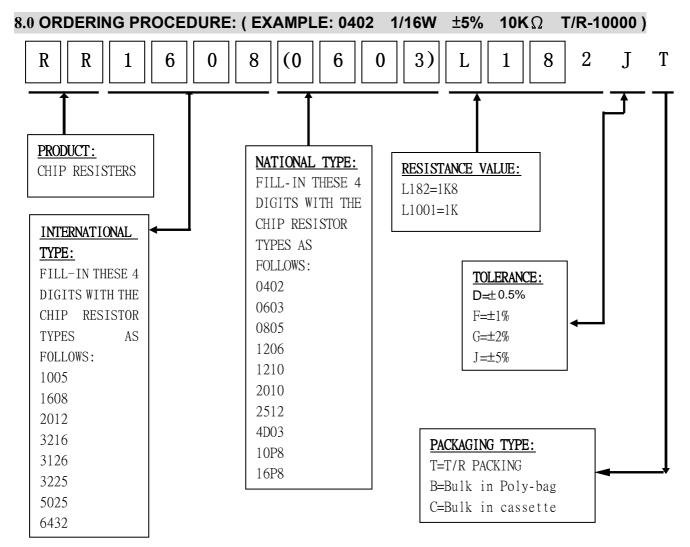
C=BULK IN (CHIP PRODUCT) T=TAPE/REEL

7.4.4 THE 13TH DIGIT IS NORMALLY TO INDICATE THE PACKING QUANTITY OF TAPE/BOX & TAPE/REEL PACKAGING TYPES. THE FOLLOWING LETTER CODE IS TO BE USED FOR SOME PACKING QUANTITIES:

CHIP PRODUCT: BD=B/B-20000PCS TC=T/R-10000PCS

7.4.5 FOR SOME ITEMS, THE 14TH DIGIT ALONE CAN USE TO DENOTE SPECIAL FEATURES OF ADDITIONAL INFORMATION WITH THE FOLLOWING CODES:

E=FOR "ENVIRONMENTAL PROTECTION, LEAD FREE TYPE" OF CHIP, CHIP ARRAY OR CHIP NETWORK RESISTORS.

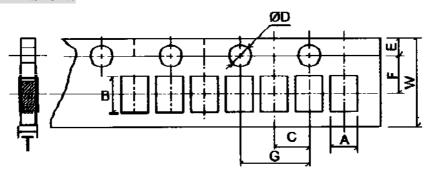


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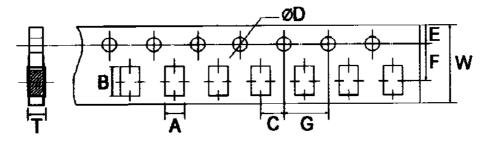
9.0 PACKAGING:

9.1 TAPPING DIMENSION:



UNIT: mm

TYPE	A	В	C±0.05	+0.1 ⊕D -0	E±0.1	F±0.05	G±0.1	W±0.2	T±0.1
0201	0.4±0.05	0.7±0.05	2.0	1.5	1.75	3.5	4.0	8.0	0.42
0402	0.65±0.2	1.15±0.2	2.0	1.5	1.75	3.5	4.0	8.0	0.45

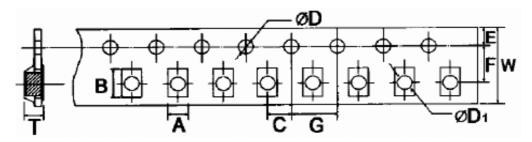


UNIT: mm

TYPE	A ±0.2	B ±0.2	C±0.05	+0.1 ΦD -0	E±0.1	F±0.05	G±0.1	W±0.2	T±0.1
0603	1.10	1.90	2.0	1.5	1.75	3.5	4.0	8.0	0.67
0805	1.65	2.40	2.0	1.5	1.75	3.5	4.0	8.0	0.81
1206	2.00	3.60	2.0	1.5	1.75	3.5	4.0	8.0	0.81
1210	2.80	3.50	2.0	1.5	1.75	3.5	4.0	8.0	0.75
2010	2.80	5.40	2.0	1.5	1.75	5.5	4.0	12.0	0.75

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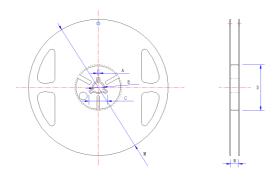




UNIT: mm

TYPE	A±0.2	B±0.2	C±0.05	+ 0.1 φD - 0	+0.25 φD1 -0	E±0.1	F±0.05	G±0.1	W±0.2	T±0.1
2512	3.5	6.7	2.0	1.5	1.5	1.75	5.5	4.0	12	1.0

9.2 DIMENSION:



UNIT: mm

TYPE	TAPING	QTY/REEL	A±0.5	B±0.5	C±0.5	D±1	M±2	W±1
0201	PAPER	10,000PCS	2.0	13.0	21.0	60.0	178	10
0402	PAPER	10,000PCS	2.0	13.0	21.0	60.0	178	10
0603	PAPER	5,000PCS	2.0	13.0	21.0	60.0	178	10
0805	PAPER	5,000PCS	2.0	13.0	21.0	60.0	178	10
1206	PAPER	5,000PCS	2.0	13.0	21.0	60.0	178	10
1210	PAPER	5,000PCS	2.0	13.0	21.0	60.0	178	10
2010	PAPER OR EMBOSSED	4,000PCS	2.0	13.0	21.0	60.0	178	13.8
2512	EMBOSSED	4,000PCS	2.0	13.0	21.0	60.0	178	13.8

10.0 NOTE MATTER:

10.1 SUPEROHM RECOMMEND THE STORAGE CONDITION TEMPERATURE: 15° C ~ 35° C, HUMIDITY :25%~75%.(PUT CONDITION FOR INDIVIDUAL PRODUCT).EVEN UNDER SUPEROHM RECOMMENDED STORAGE CONDITION, SOLDERABILITY OF PRODUCTS OVER 1 YEAR OLD(PUT CONDITION FOR EACH PRODUCT) MAY BE DEGRADED.

10.2 STORE / TRANSPORT CARTONS IN THE CORRECT DIRECTION, WHICH IS INDICATED ON A CARTON AS A SYMBOL.OTHERWISE BENT LEADS MAY OCCUR DUE TO EXCESSIVE

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- STRESS APPLIED WHEN DROPPING OF A CARTON.
- 10.3 PRODUCT PERFORMANCE AND SOLDERED CONNECTIONS MAY DETERIORATE IF THE PRODUCTS ARE STORED IN THE FOLLOWING PLACES:
 - A. STORAGE IN HIGH ELECTROSTATIC.
 - B. STORAGE IN DIRECT SUNSHINE . RAIN AND SNOW OR CONDENSATION.
 - C. WHERE THE PRODUCTS ARE EXPOSED TO SEA WINDS OR CORROSIVE GASES, INCLUDING CL_2 , H_2S_3 NH_3 , SO_2 , NO_2 .
- 10.4 THE PRODUCTS ARE USED IN CIRCUIT BOARD THICKNESS GREATER THAN 1.6mm. IF CUSTOMERS USE LESS THAN THE THICKNESS OF THE CIRCUIT BOARD THAT YOU SHOULD CONFIRM WITH THE COMPANY, IN ORDER TO RECOMMEND A MORE SUITABLE PRODUCT.

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